Preferred Device

# **Silicon Controlled Rectifiers**

## **Reverse Blocking Thyristors**

Designed primarily for half-wave ac control applications, such as motor controls, heating controls and power supply crowbar circuits.

#### Features

- Glass Passivated Junctions with Center Gate Fire for Greater Parameter Uniformity and Stability
- Small, Rugged, Thermowatt Constructed for Low Thermal Resistance, High Heat Dissipation and Durability
- Blocking Voltage to 800 Volts
- 300 A Surge Current Capability
- Pb–Free Packages are Available\*



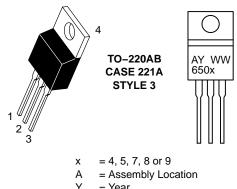
## **ON Semiconductor®**

http://onsemi.com

SCRs 25 AMPERES RMS 50 thru 800 VOLTS



#### MARKING DIAGRAM



Y = Year WW = Work Week

	PIN ASSIGNMENT
1	Cathode
2	Anode
3	Gate
4	Anode

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
*Peak Repetitive Off–State Voltage (Note 1) (Gate Open, Sine Wave 50 to 60 Hz, T <sub>J</sub> = 25 to 125°C) 2N6504 2N6505 2N6507 2N6508 2N6509	V <sub>DRM,</sub> V <sub>RRM</sub>	50 100 400 600 800	V
On-State Current RMS (180° Conduction Angles; T <sub>C</sub> = 85°C)	I <sub>T(RMS)</sub>	25	А
Average On-State Current (180° Conduction Angles; $T_C = 85^{\circ}C$ )	I <sub>T(AV)</sub>	16	А
Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T <sub>J</sub> = 100°C)	I <sub>TSM</sub>	250	А
Forward Peak Gate Power (Pulse Width $\leq$ 1.0 µs, T <sub>C</sub> = 85°C)	P <sub>GM</sub>	20	W
Forward Average Gate Power (t = 8.3 ms, $T_C = 85^{\circ}C$ )	P <sub>G(AV)</sub>	0.5	W
Forward Peak Gate Current (Pulse Width $\leq$ 1.0 $\mu$ s, T <sub>C</sub> = 85°C)	I <sub>GM</sub>	2.0	А
Operating Junction Temperature Range	TJ	-40 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to +150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
*Thermal Resistance, Junction-to-Case	$R_{ ext{ heta}JC}$	1.5	°C/W
*Maximum Lead Temperature for Soldering Purposes 1/8 in from Case for 10 Seconds	TL	260	°C

#### ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				-	
* Peak Repetitive Forward or Reverse Blocking Current ( $V_{AK}$ = Rated $V_{DRM}$ or $V_{RRM}$ , Gate Open) $T_J = 25^{\circ}C$ $T_J = 125^{\circ}C$	I <sub>DRM</sub> , I <sub>RRM</sub>			10 2.0	μA mA
ON CHARACTERISTICS					
*Forward On-State Voltage (Note 2) (I <sub>TM</sub> = 50 A)	V <sub>TM</sub>	_	-	1.8	V
	I <sub>GT</sub>		9.0 -	30 75	mA
*Gate Trigger Voltage (Continuous dc) (V <sub>AK</sub> = 12 Vdc, R <sub>L</sub> = 100 $\Omega$ , T <sub>C</sub> = -40°C)	V <sub>GT</sub>	-	1.0	1.5	V
Gate Non-Trigger Voltage (V <sub>AK</sub> = 12 Vdc, R <sub>L</sub> = 100 $\Omega$ , T <sub>J</sub> = 125°C)	V <sub>GD</sub>	0.2	-	-	V
*Holding Current $T_C = 25^{\circ}C$ (V <sub>AK</sub> = 12 Vdc, Initiating Current = 200 mA, Gate Open) $T_C = -40^{\circ}C$	Ι <sub>Η</sub>	-	18 -	40 80	mA
*Turn-On Time (I <sub>TM</sub> = 25 A, I <sub>GT</sub> = 50 mAdc)	t <sub>gt</sub>	_	1.5	2.0	μs
Turn-Off Time (V <sub>DRM</sub> = rated voltage) ( $I_{TM} = 25 \text{ A}, I_R = 25 \text{ A}$ ) ( $I_{TM} = 25 \text{ A}, I_R = 25 \text{ A}, T_J = 125^{\circ}\text{C}$ )	tq		15 35		μs
DYNAMIC CHARACTERISTICS	÷	-	-	•	

Critical Rate of Rise of Off-State Voltage (Gate Open, Rated V <sub>DRM</sub> , Exponential Waveform)	dv/dt	-	50	-	V/µs

\*Indicates JEDEC Registered Data.

2. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.

## Voltage Current Characteristic of SCR

		+ Current Anode +
Symbol	Parameter	
V <sub>DRM</sub>	Peak Repetitive Off State Forward Voltage	
IDRM	Peak Forward Blocking Current	on state ´
V <sub>RRM</sub>	Peak Repetitive Off State Reverse Voltage	I <sub>RRM</sub> at V <sub>RRM</sub>
I <sub>RRM</sub>	Peak Reverse Blocking Current	
V <sub>TM</sub>	Peak On State Voltage	+ Voltage
I <sub>H</sub>	Holding Current	Reverse Blocking Region
		(off state)       Forward Blocking Region         Reverse Avalanche Region       (off state)         Anode –
13 0 12 0 110 10 90	$\alpha = \text{CONDUCTION AI}$	$\frac{1}{16}$
90 5 80	$\alpha = 30^{\circ}$ $60^{\circ}$ $90^{\circ}$ $180^{\circ}$	
0	4.0 8.0 12 16	20 0 4.0 8.0 12 16 2
	I <sub>T(AV)</sub> , ON-STATE FORWARD CURRENT (AMPS)	I <sub>T(AV)</sub> , AVERAGE ON-STATE FORWARD CURRENT (AMPS)

Figure 1. Average Current Derating

Figure 2. Maximum On–State Power Dissipation

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
2N6404	TO-220AB	
2N6405	TO-220AB	
2N6405T	TO-220AB	
2N6407	TO-220AB	
2N6407T	TO-220AB	
2N6407TG	TO-220AB (Pb-Free)	500 Units / Box
2N6408	TO-220AB	
2N6408G	TO-220AB (Pb-Free)	
2N6409	TO-220AB	
2N6409G	TO-220AB (Pb-Free)	
2N6409T	TO-220AB	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

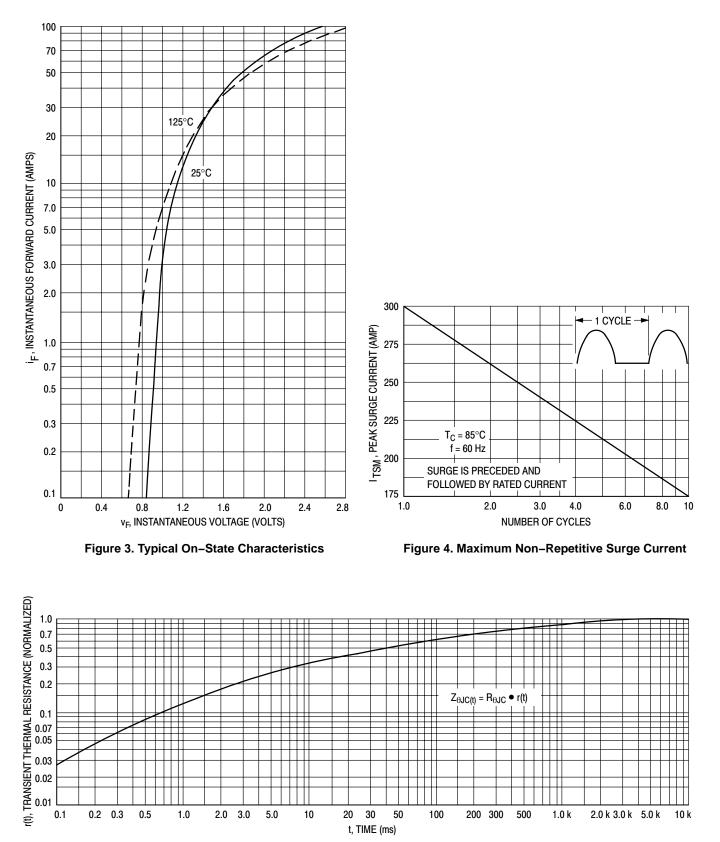
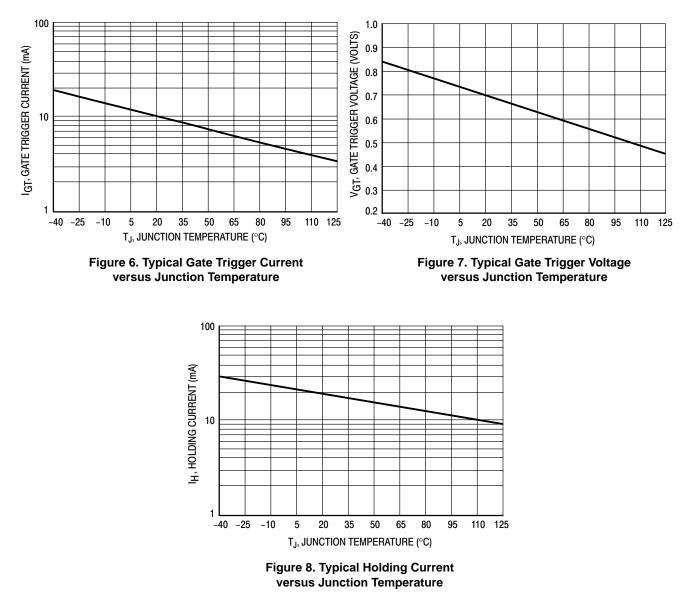


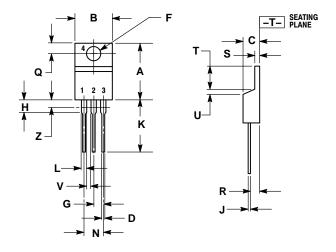
Figure 5. Thermal Response

### TYPICAL TRIGGER CHARACTERISTICS



#### PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 ISSUE AA



NOTES:

 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.

 CONTROLLING DIMENSION: INCH.
 DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
Κ	0.500	0.562	12.70	14.27
Г	0.045	0.060	1.15	1.52
Ν	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
۷	0.045		1.15	
Ζ		0.080		2.04

PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE

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